

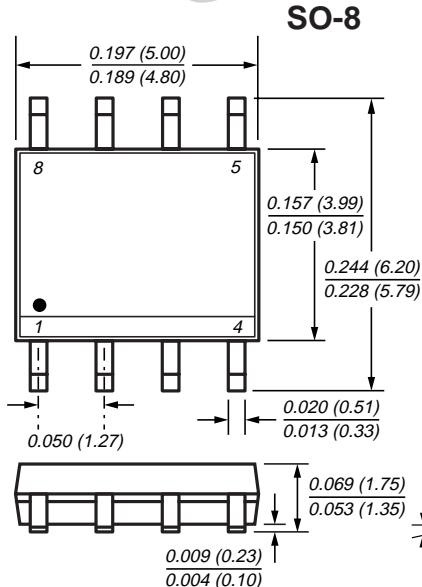


TRENCH
GENFET®

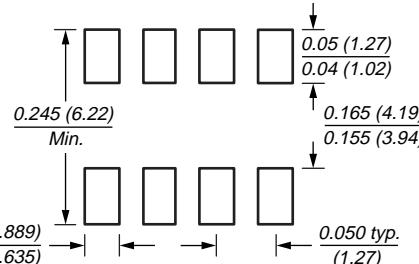
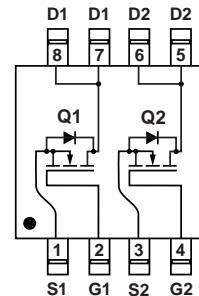
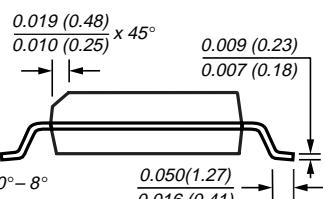
Dual N-Channel Enhancement-Mode MOSFET

V_{DS} 30V $R_{DS(ON)}$ 18mΩ I_D 7.8A

New Product



Dimensions in inches
and (millimeters)



Mounting Pad Layout

Mechanical Data

Case: SO-8 molded plastic body

Terminals: Leads solderable per MIL-STD-750, Method 2026

High temperature soldering guaranteed:
250°C/10 seconds at terminals

Mounting Position: Any

Weight: 0.5g

Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for Low Voltage DC/DC Converters
- Fast Switching for High Efficiency
- Logic Level

Maximum Ratings and Thermal Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current	I_D	7.8	A
Pulsed Drain Current	I_{DM}	30	
Maximum Power Dissipation ⁽¹⁾	P_D	2.0 1.3	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150	°C
Maximum Junction-to-Ambient ⁽¹⁾ Thermal Resistance	$R_{\theta JA}$	62.5	°C/W

Notes:

(1) Surface mounted on FR4 board, $t \leq 10$ sec.

(2) Pulse test; pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$

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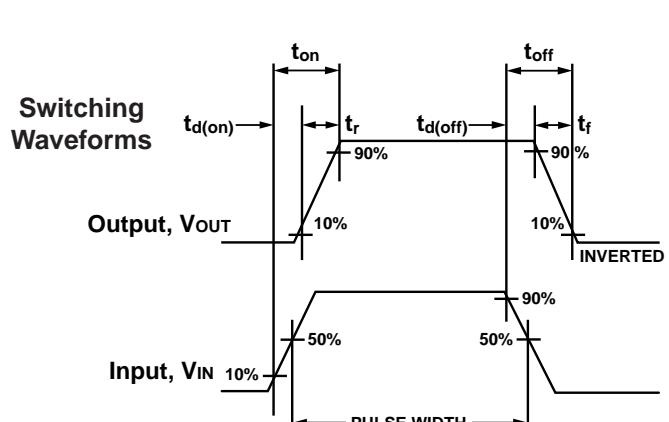
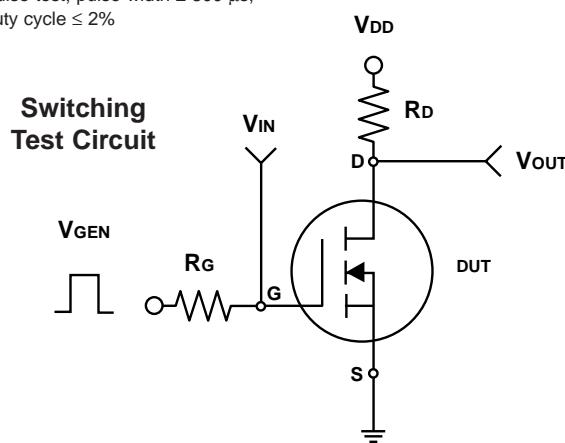
Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$	30	—	—	V
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$	1.0	—	3.0	V
Gate-Body Leakage	I_{GSS}	$\text{V}_{\text{DS}} = 0\text{V}, \text{V}_{\text{GS}} = \pm 20\text{V}$	—	—	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}} = 30\text{V}, \text{V}_{\text{GS}} = 0\text{V}$	—	—	1	μA
On-State Drain Current ⁽²⁾	$\text{I}_{\text{D(on)}}$	$\text{V}_{\text{DS}} \geq 5\text{V}, \text{V}_{\text{GS}} = 10\text{V}$	30	—	—	A
Drain-Source On-State Resistance ⁽²⁾	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 7.8\text{A}$	—	15.5	18	$\text{m}\Omega$
		$\text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 6.3\text{A}$	—	20.5	28	
Forward Transconductance ⁽²⁾	g_{fs}	$\text{V}_{\text{DS}} = 15\text{V}, \text{I}_D = 7.8\text{A}$	—	27	—	S
Dynamic						
Total Gate Charge	Q_g	$\text{V}_{\text{DS}} = 15\text{V}, \text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 7.8\text{A}$	—	19	27	nC
Gate-Source Charge	Q_{gs}	$\text{V}_{\text{DS}} = 15\text{V}, \text{V}_{\text{GS}} = 10\text{V}$ $\text{I}_D = 7.8\text{A}$	—	38	54	
Gate-Drain Charge	Q_{gd}		—	5.8	—	
Turn-On Delay Time	$\text{t}_{\text{d(on)}}$		—	10	20	ns
Rise Time	t_r	$\text{V}_{\text{DD}} = 15\text{V}, \text{R}_L = 15\Omega$ $\text{I}_D \approx 1\text{A}, \text{V}_{\text{GEN}} = 10\text{V}$ $\text{R}_G = 6\Omega$	—	10	20	
Turn-Off Delay Time	$\text{t}_{\text{d(off)}}$		—	51	77	
Fall Time	t_f		—	21	38	
Input Capacitance	C_{iss}	$\text{V}_{\text{GS}} = 0\text{V}$	—	1885	—	pF
Output Capacitance	C_{oss}	$\text{V}_{\text{DS}} = 15\text{V}$	—	325	—	
Reverse Transfer Capacitance	C_{rss}	$f = 1.0\text{MHz}$	—	180	—	
Source-Drain Diode						
Maximum Diode Forward Current	I_s				1.7	A
Diode Forward Voltage ⁽²⁾	V_{SD}	$\text{I}_s = 1.7\text{A}, \text{V}_{\text{GS}} = 0\text{V}$	—	0.75	1.2	V

Notes:

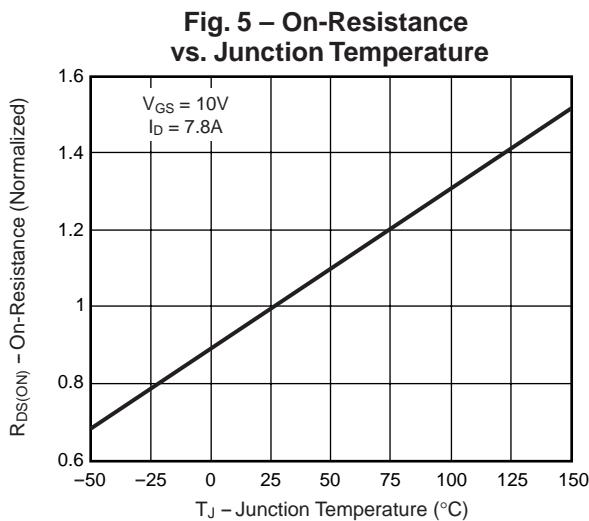
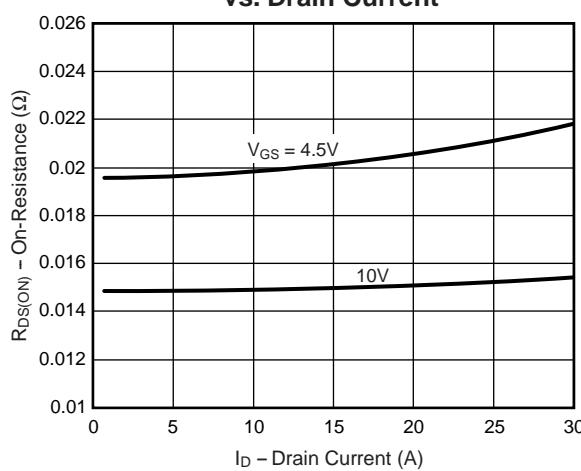
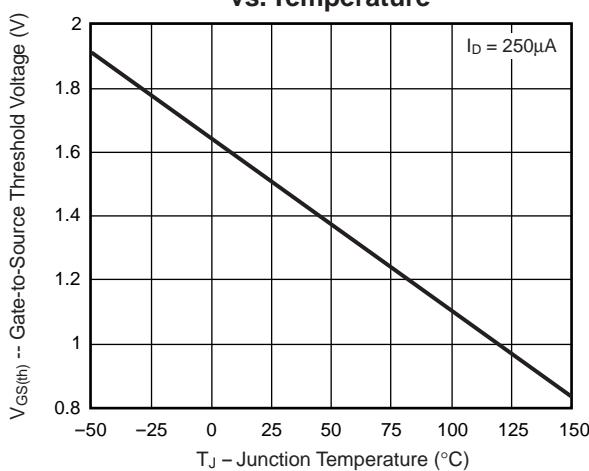
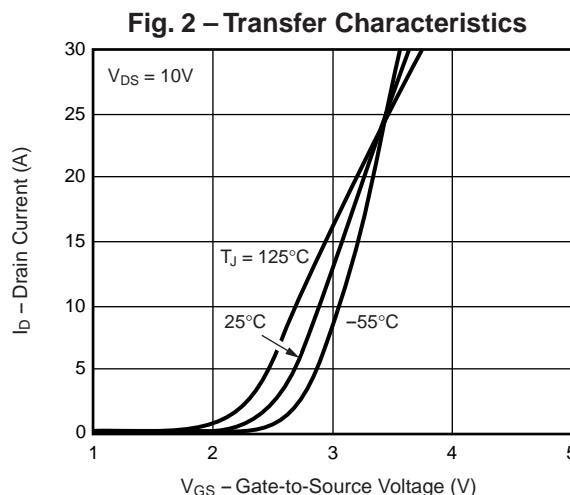
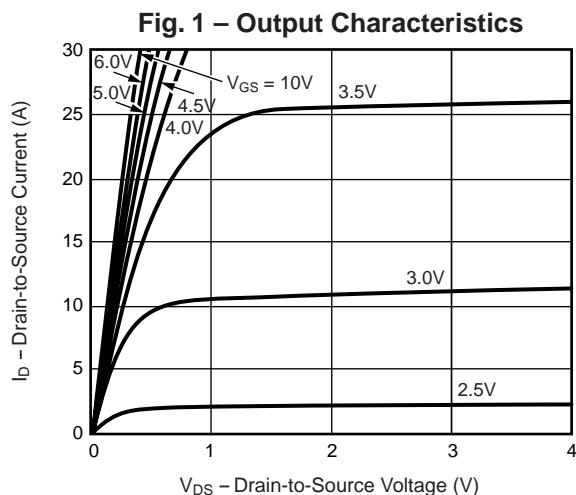
(1) Surface mounted on FR4 board, $t \leq 10$ sec.

(2) Pulse test; pulse width $\leq 300 \mu\text{s}$,
duty cycle $\leq 2\%$



Dual N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves ($T_A = 25^\circ\text{C}$ unless otherwise noted)



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**Fig. 6 – On-Resistance
vs. Gate-to-Source Voltage**

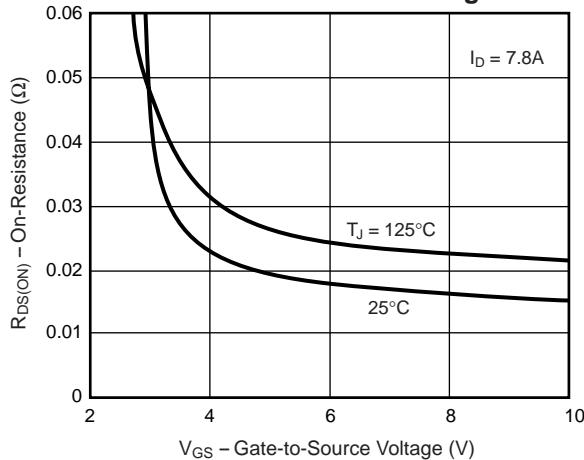


Fig. 7 – Gate Charge

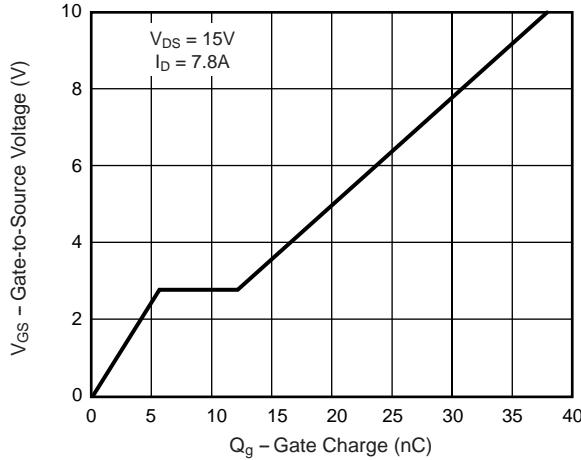
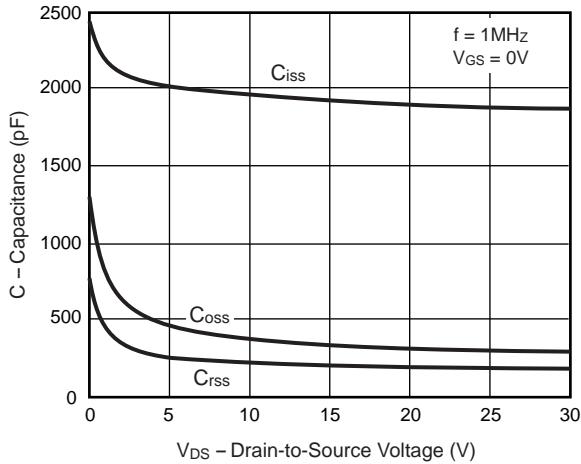
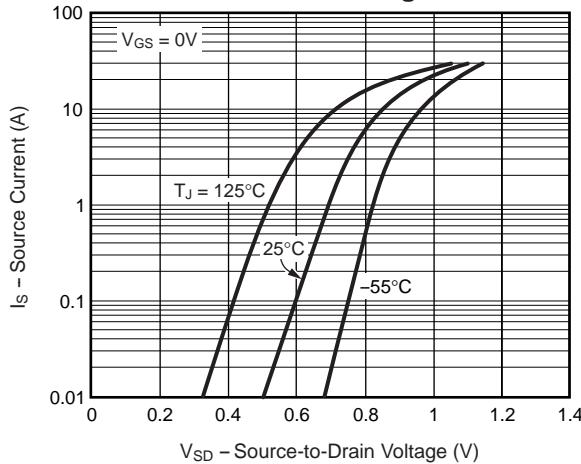


Fig. 8 – Capacitance



**Fig. 9 – Source-Drain Diode
Forward Voltage**



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Fig. 10 – Breakdown Voltage vs. Junction Temperature

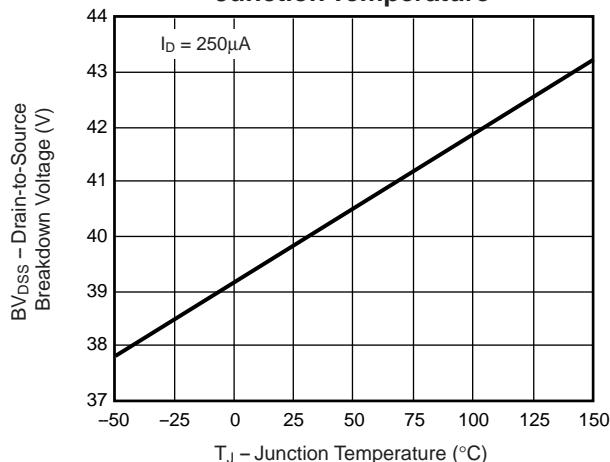


Fig. 12 – Power vs. Pulse Duration

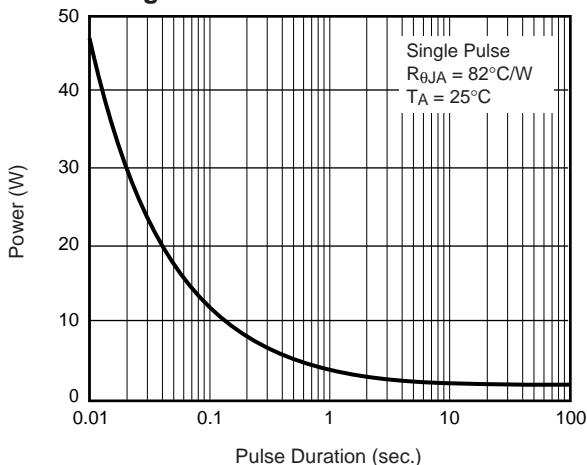


Fig. 11 – Thermal Impedance

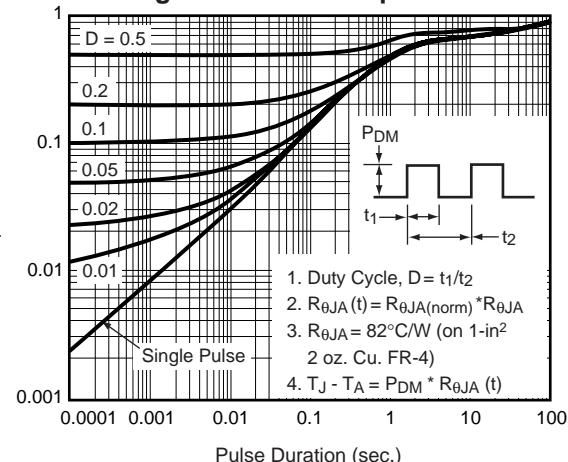


Fig. 13 – Maximum Safe Operating Area

